

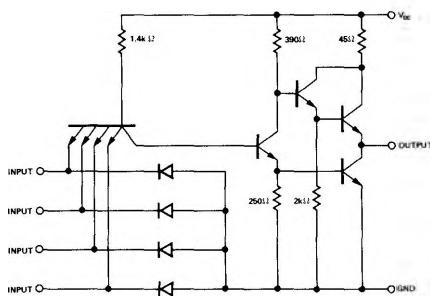
DUAL 4-INPUT POSITIVE NAND BUFFER

**S54H40
N74H40**

S54H40-A,F,W • N74H40-A,F

DIGITAL 54/74 TTL SERIES

SCHEMATIC (each gate)

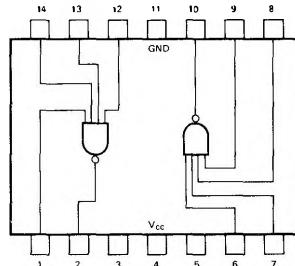


NOTES:

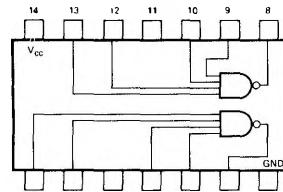
1. Component values shown are nominal.

PIN CONFIGURATIONS

W PACKAGE



A,F PACKAGE



RECOMMENDED OPERATING CONDITIONS

	MIN	NOM	MAX	UNIT
Supply Voltage V_{CC} : S54H40 Circuits	4.5	5	5.5	V
N74H40 Circuits	4.75	5	5.25	V
Normalized Fan-Out from each Output, N			30	
Operating Free-Air Temperature Range, T_A : S54H40 Circuits	-55	25	125	$^{\circ}\text{C}$
N74H40 Circuits	0	25	70	$^{\circ}\text{C}$

ELECTRICAL CHARACTERISTICS (over recommended operating free-air temperature range unless otherwise noted)

PARAMETER	TEST CONDITIONS*	TEST CONDITIONS*			UNIT
		MIN	TYP [†]	MAX	
$V_{in(1)}$	$V_{CC} = \text{MIN}$,		2		V
$V_{in(0)}$	$V_{CC} = \text{MIN}$,			0.8	V
$V_{out(1)}$	$V_{CC} = \text{MIN}$, $I_{load} = -1.5\text{mA}$	$V_{in} = 0.8\text{V}$,	2.4		V
$V_{out(0)}$	$V_{CC} = \text{MIN}$, $I_{sink} = 60\text{mA}$	$V_{in} = 2\text{V}$,		0.4	V
$I_{in(0)}$	$V_{CC} = \text{MAX}$,	$V_{in} = 0.4\text{V}$		-4	mA
$I_{in(1)}$	$V_{CC} = \text{MAX}$, $V_{CC} = \text{MAX}$,	$V_{in} = 2.4\text{V}$ $V_{in} = 5.5\text{V}$		100 1	μA mA
I_{OS}	$V_{CC} = \text{MAX}$		-40	-125	mA
$I_{CC(0)}$	$V_{CC} = \text{MAX}$,	$V_{in} = 4.5\text{V}$	25	40	mA
$I_{CC(1)}$	$V_{CC} = \text{MAX}$,	$V_{in} = 0$	10.4	16	mA

Logical 1 input voltage required at all input terminals to ensure logical 0 level at output

Logical 0 input voltage required at any input terminal to ensure logical 1 level at output

Logical 1 output voltage

Logical 0 output voltage

Logical 0 level input current (each input)

Logical 1 level input current (each input)

Short circuit output current**

Logical 0 level supply current

Logical 1 level supply current

$V_{CC} = \text{MIN}$,

$V_{CC} = \text{MIN}$,

$V_{CC} = \text{MIN}$,
 $I_{load} = -1.5\text{mA}$

$V_{CC} = \text{MIN}$,
 $I_{sink} = 60\text{mA}$

$V_{CC} = \text{MAX}$,

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$V_{CC} = \text{MAX}</math$

SIGNETICS DIGITAL 54/74 TTL SERIES — S54H40 • N74H40SWITCHING CHARACTERISTICS, $V_{CC} = 5V$, $T_A = 25^\circ C$, $N = 30$

PARAMETER	TEST CONDITIONS	MIN	TYP	MAX	UNIT
t_{pd0}	Propagation delay time to logical 0 level $C_L = 25pF$, $R_L = 93\Omega$	6.5	12		ns
t_{pd1}	Propagation delay time to logical 1 level $C_L = 25pF$, $R_L = 93\Omega$	8.5	12		ns

* For conditions shown as MIN or MAX, use the appropriate value specified under recommended operating conditions for the applicable device type.

** Not more than one output should be shorted at a time, and duration of short circuit test should not exceed 1 second.

† All typical values are at $V_{CC} = 5V$, $T_A = 25^\circ C$.